

<b>Notice of References Cited</b>	Application/Control No. 09/976,626		Applicant(s)/Patent Under Reexamination HAINES ET AL.	
	Examiner Michael D. Meucci		Art Unit 2142	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,580,177	12-1996	Gase et al.	400/61
*	B	US-6,333,790 B1	12-2001	Kageyama, Seiji	358/1.15
*	C	US-2002/0059415 A1	05-2002	Chang et al.	709/223
*	D	US-2002/0065873 A1	05-2002	Ishizuka, Hiroaki	709/203
*	E	US-2002/0181010 A1	12-2002	Pineau, Richard A.	358/1.15
*	F	US-2002/0198969 A1	12-2002	Engel et al.	709/220
*	G	US-6,952,731 B1	10-2005	Picca et al.	709/225
*	H	US-2007/0022180 A1	01-2007	Cocotis et al.	709/217
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.